

## **MES FIELD EFFECT TRANSISTOR**

## 3SK177

# RF AMP. FOR UHF TV TUNER N-CHANNEL GaAs DUAL-GATE MES FIELD-EFFECT TRANSISTOR 4 PIN MINI MOLD

### **FEATURES**

• Suitable for use as RF amplifier in UHF TV tuner.

Low Crss: 0.02 pF TYP.High GPS: 20 dB TYP.Low NF: 1.1 dB TYP.

## ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage	V <sub>DSX</sub>	13	V
Gate 1 to Source Voltage	V <sub>G1S</sub>	-4.5	V
Gate2 to Source Voltage	V <sub>G2</sub> S	-4.5	V
Drain Current	lο	40	mΑ
<b>Total Power Dissipation</b>	Рт	200	mW
Channel Temperature	Tch	125	°C
Storage Temperature	Tstg	-55 to +125	°C

# PACKAGE DIMENSIONS in millimeters 2.8<sup>+0.3</sup> 2.8<sup>+0.3</sup>

## ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Drain to Source Breakdown Voltage	BV <sub>DSX</sub>	13			٧	$V_{G1S} = -4 \text{ V}, V_{G2S} = 0, I_D = 10 \mu A$	
Drain Current	IDSS	5	20	40	mA	VDS = 5 V, VG2S = 0, VG1S = 0	
Gate1 to Source Cutoff Voltage	V <sub>G1S(off)</sub>			-3.5	V	$V_{DS} = 5 \text{ V}, V_{G2S} = 0, I_{D} = 100 \mu\text{A}$	
Gate2 TO Source Cutoff Voltage	V <sub>G2S(off)</sub>			-3.5	V	$V_{DS} = 5 \text{ V}, V_{G1S} = 0, I_{D} = 100 \mu A$	
Gate1 Reverse Current	I <sub>G1</sub> ss			10	μΑ	V <sub>DS</sub> = 0, V <sub>G1S</sub> = -4 V, V <sub>G2S</sub> = 0	
Gate2 Reverse Current	I <sub>G2</sub> ss			10	μΑ	V <sub>DS</sub> = 0, V <sub>G2S</sub> = -4 V, V <sub>G1S</sub> = 0	
Forward Transter Admittance	yfs	18	25	35	ms	V <sub>DS</sub> = 5 V, V <sub>G2S</sub> = 1 V, I <sub>D</sub> = 10 mA, f = 1.0 kHz	
Input Capacitance	Ciss	0.5	1.0	1.5	pF	V <sub>DS</sub> = 5 V, V <sub>G2S</sub> = 1 V, I <sub>D</sub> = 10 mA,	
Reverse Transfer Capacitance	Crss		0.02	0.03	pF	f = 1 MHz	
Power Gain	GPS	16.0	20.0		dB	VDS = 5 V, VG2S = 1 V, ID = 10 mA,	
Noise Figure	NF		1.1	2.5	dB	f = 900 MHz	

Unit: mA

loss Classification

Class	U71	U72	U73	U74
Marking	U71	U72	U73	U74
IDSS	5 to 15	10 to 25	20 to 35	30 to 40

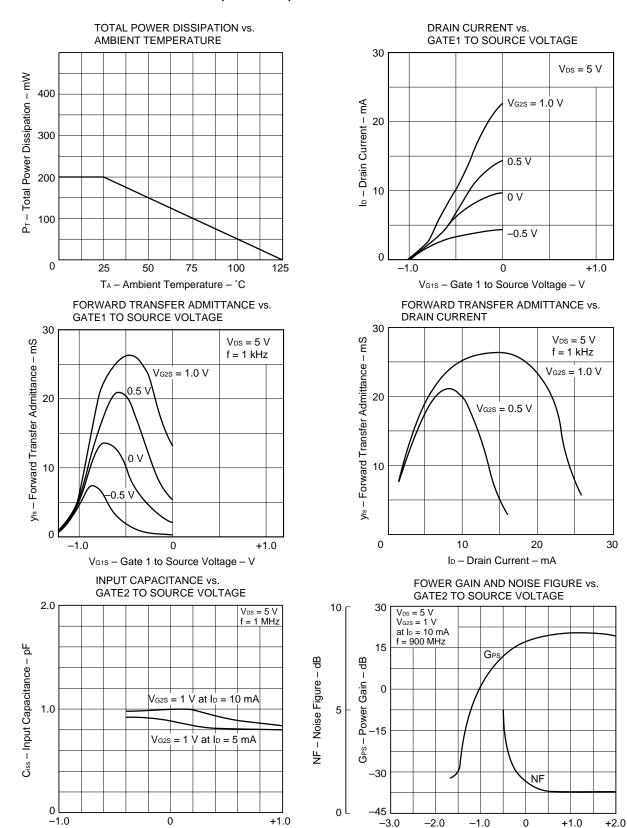
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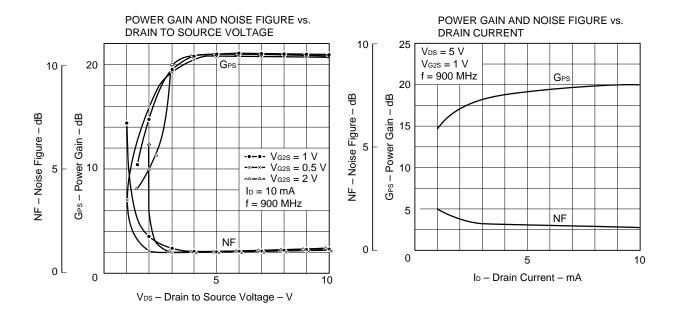
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## TYPICAL CHARACTERISTICS (TA = 25 °C)



V<sub>G2S</sub> - Gate 2 to Source Voltage - V

V<sub>G2S</sub> - Gate 2 to Source Voltage - V

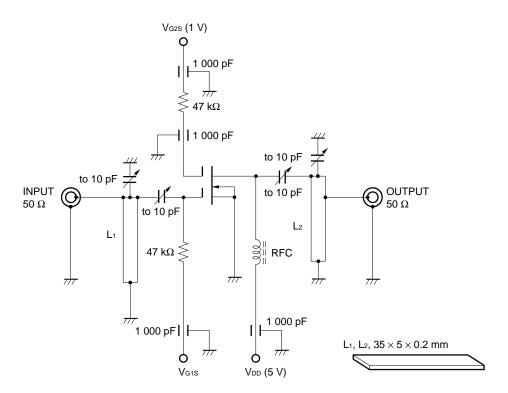


## S-PARAMETER (VDS = 5 V, VG2S = 1 V, ID = 10 mA)

FREQUENCY	:	S11	S	21	S1	2	S2	2
MHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
100.0000	0.999	-3.3	2.359	177.2	0.006	-122.3	0.969	-1.3
200.0000	1.000	-7.2	2.389	169.3	0.004	123.0	0.981	-2.9
300.0000	0.998	-9.3	2.313	164.4	0.000	-145.0	0.979	-3.3
400.0000	0.974	-13.4	2.233	160.0	0.004	79.2	0.967	-5.6
500.0000	1.005	-15.7	2.420	158.4	0.007	29.7	0.999	-5.8
600.0000	0.942	-19.1	2.300	150.0	0.003	65.0	0.958	-7.7
700.0000	0.968	-22.2	2.332	145.5	0.004	45.5	0.997	-8.5
800.0000	0.920	-25.2	2.229	141.5	0.008	80.1	0.957	-9.4
900.0000	0.952	-28.9	2.447	136.8	0.004	8.3	0.999	-12.5
1000.0000	0.898	-29.4	2.303	131.1	0.001	50.9	0.968	-11.1
1100.0000	0.915	-35.1	2.348	125.8	0.004	71.4	0.984	-14.8
1200.0000	0.879	-35.2	2.367	123.5	0.000	91.1	0.989	-13.0

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## 900 MHz GPS AND NF TEST CIRCUIT



 $V_{DS} = 5 \text{ V}, V_{G2S} = 1 \text{ V}, I_{D} = 10 \text{ mA}$ 

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Anti-radioactive design is not implemented in this product.

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